



Automated Test Equipment (ATE) NA TC Chapter

Tuesday, April 12, 2022

8:00–10:00 AM (Pacific Time)

OVTCCM

AGENDA

	Time								
1 Welcome/Call to Order	8:00-8:10								
1.1 Introductions									
1.2 Required Meeting Elements (Membership Requirements, Antitrust and Intellectual Property Reminders, and Effective Meeting Guidelines)									
1.3 Agenda Review									
2 Review of Previous Meeting Minutes (including open Action Items review)	8:10-8:15								
3 Staff Report	8:15-8:20								
4 Ballot Review (including safety and IP checks)	8:20-9:00								
<table><tr><th>#</th><th>When</th><th>TF</th><th>Details</th></tr><tr><td>6905</td><td>Cycle 2-2022</td><td>Rich Interactive Test Database (RITdb)</td><td>Line Item Revision to SEMI E183-1121: Specification for Rich Interactive Test Database (RITdb)</td></tr></table>		#	When	TF	Details	6905	Cycle 2-2022	Rich Interactive Test Database (RITdb)	Line Item Revision to SEMI E183-1121: Specification for Rich Interactive Test Database (RITdb)
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6905	Cycle 2-2022	Rich Interactive Test Database (RITdb)	Line Item Revision to SEMI E183-1121: Specification for Rich Interactive Test Database (RITdb)						
5 Subcommittee & Task Force Reports									
5.1 Tester Event Messaging for Semiconductors Task Force – Laurent Bonneval	9:00 – 9:10								
5.2 Rich Interactive Test Databases Task Force (RITdb) – Mark Roos / Stacy Ajouri									



7 Old Business

9:10 – 9:15

- 6.1 Standards due for Five-Year Review
- 6.2 SNARFs approaching Three-Year Document Development Project Period

8 New Business

9:15-9:20

- 7.1 New TFOFs & SNARFs
- 7.2 Authorize for Ballot
- 7.3 New Ballot(s) Submission Summary

9 New Action Item Review

9:20-9:25

10 Next Meetings Schedule (TBD)

9:25-9:30

Date/Time/Location

11 Adjournment

9:30

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